

The Testing and Test Control Notation TTETT-3

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Agenda

- Introduction
- Overview on TTCN-3
- An Example
- Test Execution
- Outlook

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TTCN-3

- A standardized alternative to propriatery test systems
 - Developed by a large group of testing experts
 - Used by a growing community
 - Proven by tools
 - Maintained at ETSI
- A test specification and implementation language
 - Test and Testing Control Notation = TTCN-3
 - Multipart standard covering
 - Testing concepts
 - Semantics
 - Presentation formats
 - Execution interfaces

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TTCN-3

- Applicable for all kinds of black-box and grey-box testing for reactive and distributed systems, e.g.
 - Fixed and mobile telecommunication (ATM, GSM, GPRS, UMTS)
 - Internet (IPv6, SIP)
 - Middleware platforms (CORBA, CCM, EJB, Web Services)
 - Embedded systems (automotive, avionics)
 - Programming interfaces (Java, XML)
- Applicable to many kinds of testing
 - Development, system, integration, interoperability, scalability ...
 - · And also conformance testing
- As a test solution in industrial software development and for standardized test suites

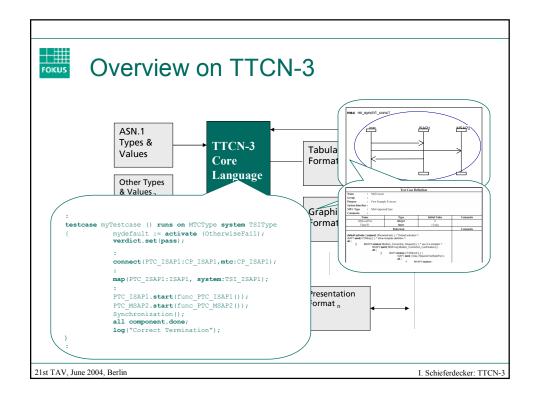
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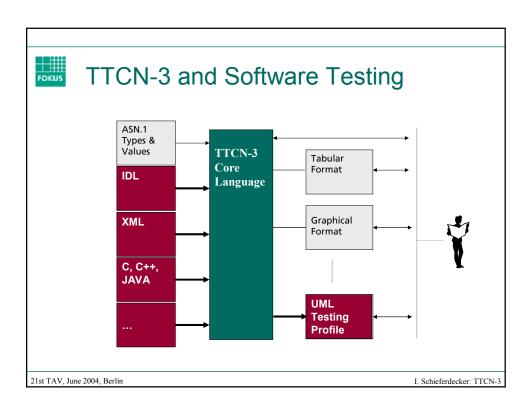


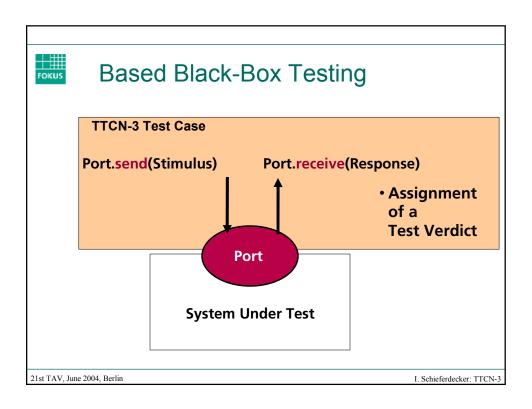
Main Aspects of TTCN-3

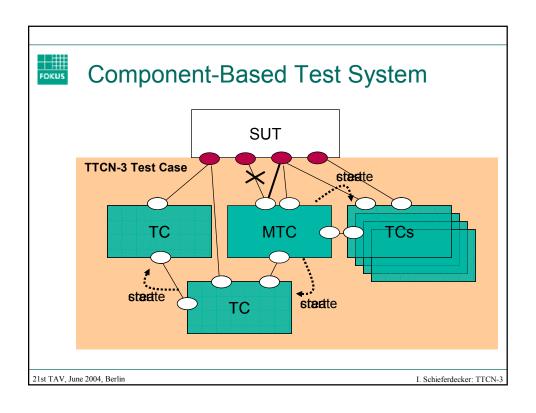
- Triple C
 - Configuration: Dynamic concurrent test configurations with test components
 - Communication: Various communication mechanisms (synchronous and asynchronous)
 - Control: Test case execution and selection mechanisms
- Improved
 - Harmonized with ASN.1
 - Module concept
- Extendibility via attributes, external function, external data
- Well-defined syntax, static and operational semantics
- Different presentation formats

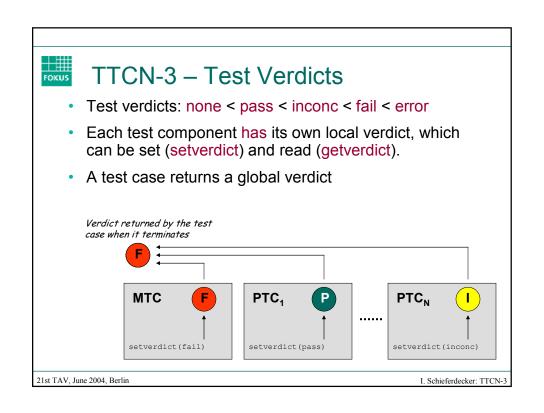
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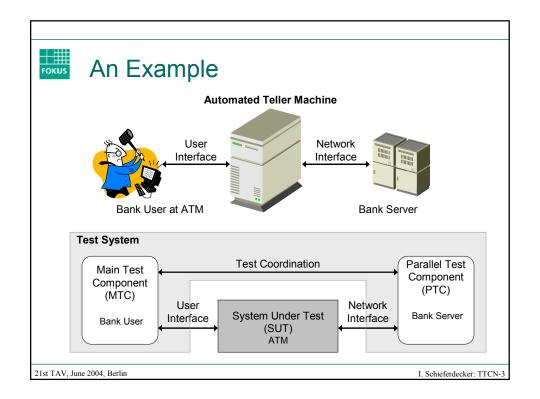




Basic Elements of TTCN-3

- Module covers declarations and control
- Templates (test data description) and matching mechanisms (pattern matching)
- Test configurations
 - Formally defined interfaces to the SUT
 - · Dynamic creation of test component
 - Concurrency to describe distributed test setups
- Test cases
 - Small (complete) separate compilable programs
 - Share (type and data) information
- Test verdicts

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```
The TTCN-3 Module
  module ATM Test {
                                     Module Parameter
    modulepar {
      float
                      maxDurOfTC Par;
      account Type validAccount Par;
                      validCard Par;
      card Type
                      validPin Par, validAmount Par;
      integer
                      maxDurOfTC par
      float
                                         Constants
    external const float TestExecutionTime;
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```

```
Test Data: Types and Ports
                                                        Message Port
   type port hardwareInterface_PType message {
    out authenticationData Type, operationHWI Type;
    in authenticationComplete_Type, operationComplete_Type,
        status Type
                                                       Message Types
     type record authenticationData Type {
      card_Type card,
       integer pin
     type record authenticationComplete Type {
      boolean success,
       reason_Type reason
     type enumerated reason_Type {
       noReason,
       unknown,
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```

```
Test Data: Templates

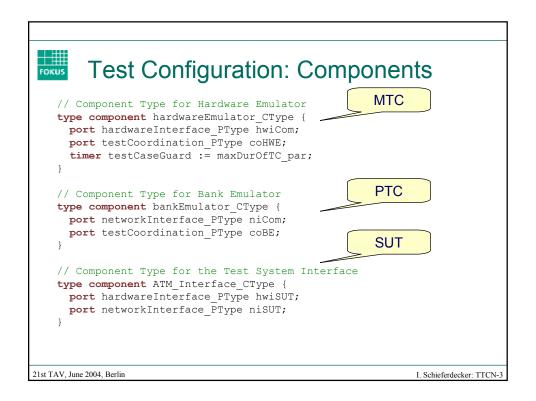
type record operationHWI_Type {
    HWI_ops operation,
    integer argument
}

Message Template

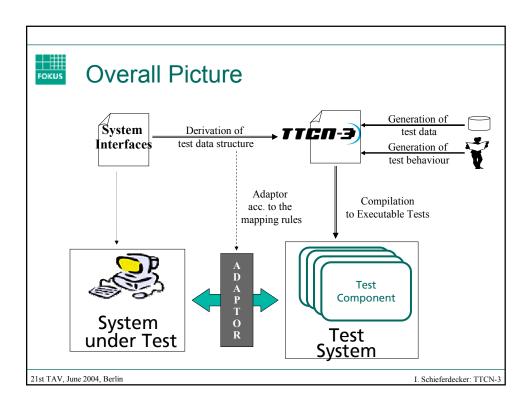
template operationHWI_Type
validWithdrawalOp_Template := {
    operation := withdrawal,
    argument := validAmount_Par
}

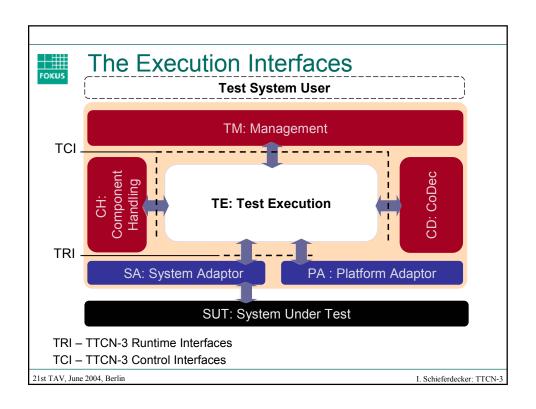
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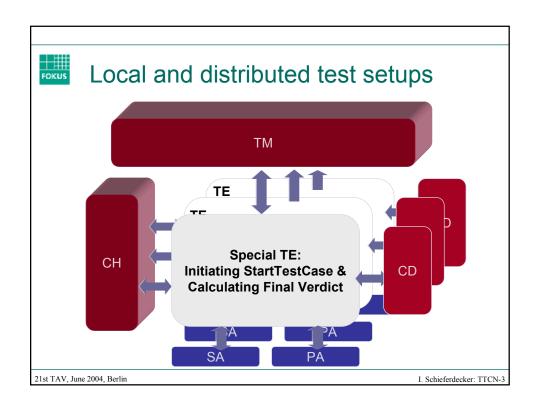
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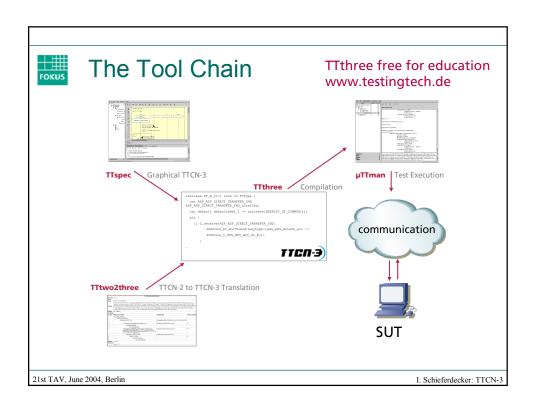


```
Test Behaviour: Test Case
   testcase validWithdrawal (inout reason Type reason)
    runs on hardwareEmulator CType system ATM Interface CType {
     var bankEmulator CType BE PTC:=bankEmulator CType.create;
                                                     PTC
     map(theSystem:niSUT, BE PTC:niCom);
     connect(self:coHWE, BE PTC:coBE);
                                                     Connections
     map(theSystem:hwiSUT, self:hwiCom);
     BE PTC.start(BE validWithdrawal());
                                                      PTC behavior
     testCaseGuard.start; // start guarding timer
     result :=
     authentication(validCard Par, validPin Par, reason);
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```











Upcoming TTCN-3

- MockUp end of 2004: mainly error correction
- New version v3.1.1 in 2005
 - Better structuring: packages, core language extensions and profile
 - Possibly support for
 - · Real-time and performance testing
 - Logging
 - Object-oriented data
 - External applications
 - · Etc.

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Summary

- TTCN-3 as the new standardized test specification and implementation language
- TTCN-3 has applications e.g. for
 - Telecommunication (e.g. mobile communication and Internet)
 - Software (e.g. object and component based systems, middleware platforms, Web services)
 - Control systems in automotive, transportation and avionics
- TTCN-3 has many tool vendors and users
- TTCN-3 is a continuously maintained and enhanced test technology

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Thank You!

Any Questions?